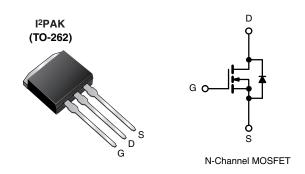
www.vishay.com

Vishay Siliconix

Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	500			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 0.85			
Q _g max. (nC)	63			
Q _{gs} (nC)	9.3			
Q _{gd} (nC)	32			
Configuration	Sin	gle		

FEATURES

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The I²PAK (TO-262) is a power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and lowest possible on-resistance. The I²PAK (TO-262) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W.

ORDERING INFORMATION	
Package	I ² PAK (TO-262)
Lead (Pb)-free and Halogen-free	SiHF840L-GE3
Lead (Pb)-free	IRF840LPbF

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V at 10 V	T _C = 25 °C T _C = 100 °C		8.0		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	5.1	Α	
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy b			E _{AS}	510	mJ	
Repetitive Avalanche Current a			I _{AR}	8.0	Α	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Dawer Dissipation	T _C =	25 °C	Б	125	W	
Maximum Power Dissipation $T_C = 100 ^{\circ}C$		P_{D}	50] vv		
Peak Diode Recovery dV/dt c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Soldering Recommendations (Peak temperature) ^d	for	10 s		300		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 14 mH, R_q = 25 Ω , I_{AS} = 8.0 A (see fig. 12)
- c. $I_{SD} \le 8.0$ A, $dI/dt \le 100$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0	G/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static						•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0	V, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I _D = 1 mA	-	0.78	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_0$	_{GS} , I _D = 250 μA	2.0	-	4.0	٧
Gate-Source Leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
Zoro Coto Voltago Drain Current		$V_{DS} = 50$	00 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 400 \text{ V}, \text{ V}$	_{'GS} = 0 V, T _J = 125 °C	1	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.8 A ^b	-	-	0.85	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 50$	V, I _D = 4.8 A ^b	4.9	-	-	S
Dynamic							
Input Capacitance	C_{iss}	V	_{GS} = 0 V,	1	1300	-	
Output Capacitance	C _{oss}	V _D	os = 25 V,	ı	310	-	рF
Reverse Transfer Capacitance	C_{rss}	f = 1.0 N	MHz, see fig. 5	1	120	-	
Total Gate Charge	Q_g		1 0 4 1/ 400 1/	1	-	63	
Gate-Source Charge	Q_gs	$V_{GS} = 10 \text{ V}$ $I_D = 8 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 b		ı	-	9.3	nC
Gate-Drain Charge	Q_gd		ground to	1	-	32	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 250 V, I_{D} = 8.0 A R_{g} = 9.1 Ω , R_{D} = 31 Ω , see fig. 10 b		-	14	-	ns
Rise Time	t _r			ı	23	-	
Turn-Off Delay Time uo	t _{d(off)}			-	49	-	
Fall Time	t _f			-	20	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from		-	4.5	-	ъЫ
Internal Source Inductance	L _S	package and cer die contact	nter of	-	7.5	-	- nH
Gate Input Resistance	R _g	f = 1 MI	Hz, open drain	0.6	-	2.8	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	showing the	MOSFET symbol showing the		-	8.0	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	32	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I	_S = 8 A, V _{GS} = 0 V ^b	-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 00 1 5	0 0 0 11/11 100 0/ h	-	460	970	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 8.0 \text{A}, \text{dI/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	4.2	8.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				12)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

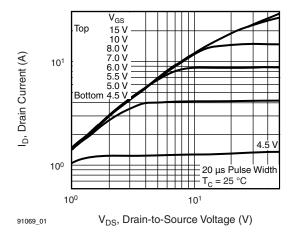


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

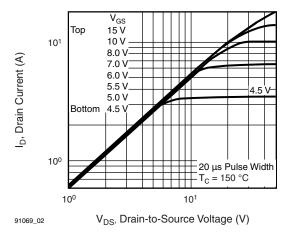


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

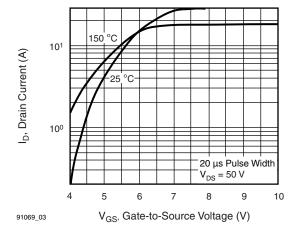


Fig. 3 - Typical Transfer Characteristics

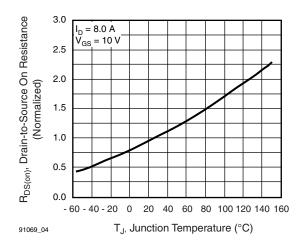


Fig. 4 - Normalized On-Resistance vs. Temperature

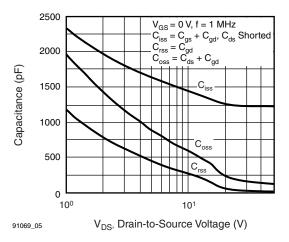


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

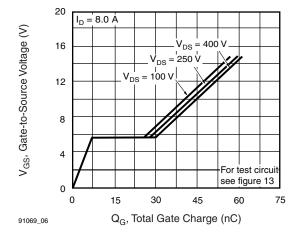


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage



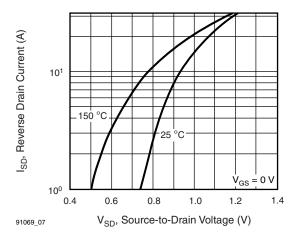


Fig. 7 - Typical Source-Drain Diode Forward Voltage

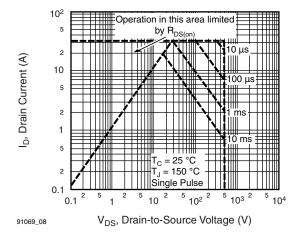


Fig. 8 - Maximum Safe Operating Area

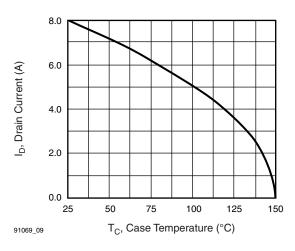


Fig. 9 - Maximum Drain Current vs. Case Temperature

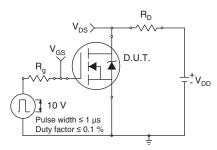


Fig. 10a - Switching Time Test Circuit

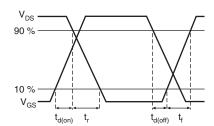


Fig. 10b - Switching Time Waveforms

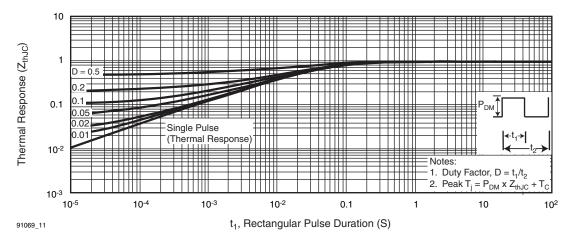


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



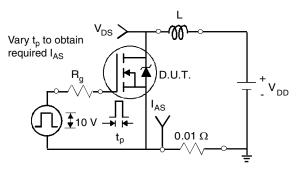


Fig. 12a - Unclamped Inductive Test Circuit

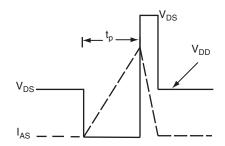


Fig. 12b - Unclamped Inductive Waveforms

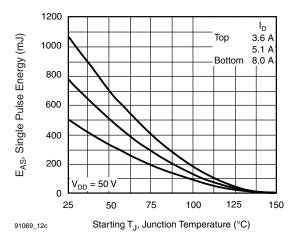


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

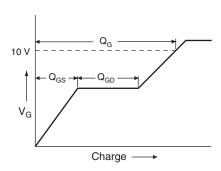


Fig. 13a - Basic Gate Charge Waveform

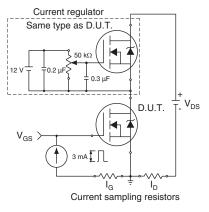
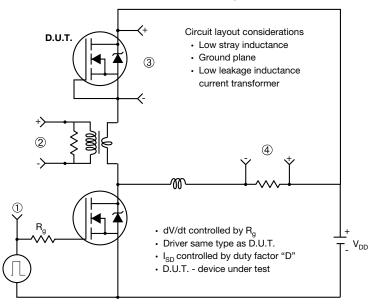


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



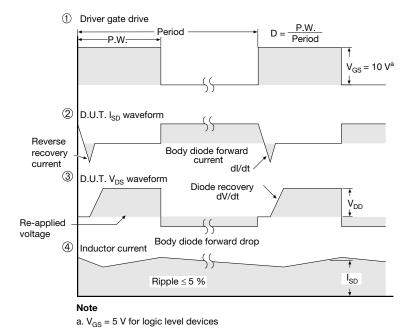


Fig. 14 - For N-Channel

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TO-263AB (HIGH VOLTAGE)







	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	i
е	2.54	BSC	0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	i	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

DWG: 5970

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).

ECN: S-82110-Rev. A, 15-Sep-08

- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08





I²PAK (TO-262) (HIGH VOLTAGE)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54	BSC	0.100	BSC
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.
- 4. Dimension b1 and c1 apply to base metal only.

Document Number: 91367 Revision: 27-Oct-08





RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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